ADC08231,ADC08234,ADC08238

ADC08231/ADC08234/ADC08238 8-Bit 2 Mus Serial I/O A/D Converters with MUX, Reference, and Track/Hold

Literature Number: SNAS067A

National Semiconductor

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ADC08231/ADC08234/ADC08238 8-Bit 2 μs Serial I/O A/D Converters with MUX, Reference, and Track/Hold

General Description

The ADC08231/ADC08234/ADC08238 are 8-bit successive approximation A/D converters with serial I/O and configurable input multiplexers with up to 8 channels. The serial I/O is configured to comply with the NSC MICROWIRE™ serial data exchange standard for easy interface to the COPS™ family of controllers, and can easily interface with standard shift registers or microprocessors.

Designed for high-speed/low-power applications, the devices are capable of a fast 2 μs conversion when used with a 4 MHz clock.

All three devices provide a 2.5V band-gap derived reference with guaranteed performance over temperature.

A track/hold function allows the analog voltage at the positive input to vary during the actual A/D conversion.

The analog inputs can be configured to operate in various combinations of single-ended, differential, or pseudo-differential modes. In addition, input voltage spans as small as 1V can be accommodated.

Applications

- High-speed data acquisition
- Digitizing automotive sensors
- Process control/monitoring
- Remote sensing in noisy environments
- Disk drives
- Portable instrumentation
- Test systems

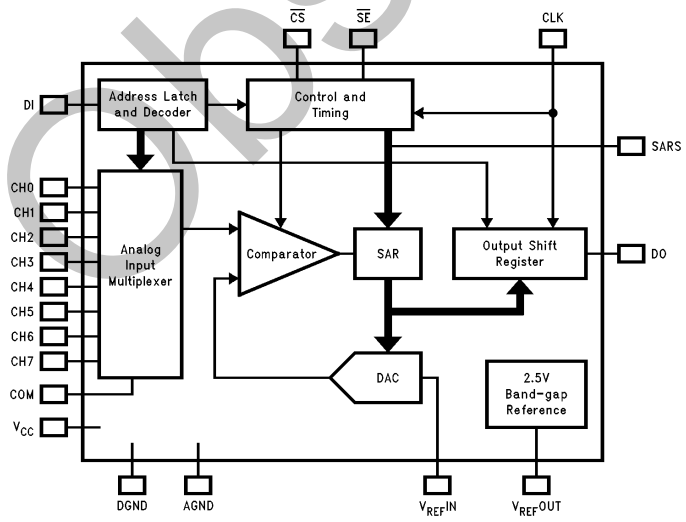
Features

- Serial digital data link requires few I/O pins
- Analog input track/hold function
- 4- or 8-channel input multiplexer options with address logic
- On-chip 2.5V band-gap reference (±2% over temperature guaranteed)
- No zero or full scale adjustment required
- TTL/CMOS input/output compatible
- 0V to 5V analog input range with single 5V power supply
- Pin compatible with Industry-Standards ADC0831/4/8

Key Specifications

- Resolution 8 Bits
- Conversion time (f_C = 4 MHz) 2 μs (Max)
- Power dissipation 20 mW (Max)
- Single supply 5 V_{DC} (±5%)
- Total unadjusted error ±½ LSB and ±1 LSB
- Linearity Error (V_{REF} = 2.5V) ±½ LSB
- No missing codes (over temperature)
- On-board Reference +2.5V ±1.5% (Max)

ADC08238 Simplified Block Diagram



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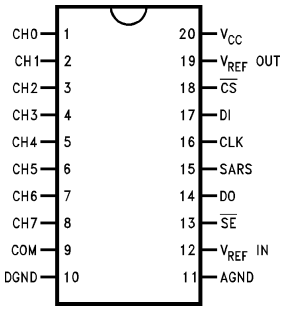
RRD-B30M75/Printed in U. S. A.

Ordering Information

Industrial ($-40°C \leq T_A \leq +85°C$)	Package
ADC08231BIN, ADC08231CIN	N08E, DIP
ADC08234BIN, ADC08234CIN	N14A, DIP
ADC08234CIMF	MTB24, TSSOP
ADC08238BIN, ADC08238CIN	N20A, DIP
ADC08231BIWM, ADC08231CIWM	M14B, SO
ADC08234BIWM, ADC08234CIWM	M14B, SO
ADC08238BIWM, ADC08238CIWM	M20B, SO

Connection Diagrams

ADC08238
SO and DIP



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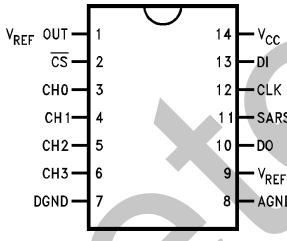
ADC08234
SO and DIP



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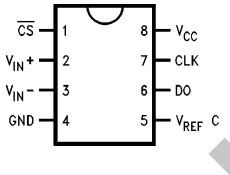
ADC08231
DIP



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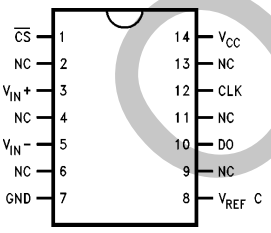
ADC08231
SO



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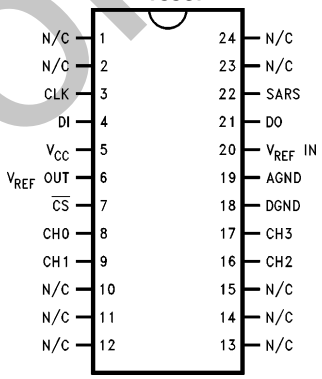
ADC08234
TSSOP



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Absolute Maximum Ratings (Notes 1 & 3)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V_{CC})	6.5V
Voltage at Inputs and Outputs	$-0.3V$ to $V_{CC} + 0.3V$
Input Current at Any Pin (Note 4)	±5 mA
Package Input Current (Note 4)	±20 mA
Power Dissipation at $T_A = 25°C$ (Note 5)	800 mW
ESD Susceptibility (Note 6)	1500V
Soldering Information	
N Package (10 sec.)	260°C
TSSOP and SO Package (Note 7):	
Vapor Phase (60 sec.)	215°C
Infrared (15 sec.)	220°C
Storage Temperature	−65°C to +150°C

Operating Ratings (Notes 2 & 3)

Temperature Range	$T_{MIN} \le T_A \le T_{MAX}$
ADC08231BIN, ADC08231CIN, ADC08234BIN, ADC08234CIN, ADC08238BIN, ADC08238CIN, ADC08231BIWM, ADC08231CIWM, ADC08234BIWM, ADC08238BIWM, ADC08234CIWM, ADC08238CIWM, ADC08234CIMF	$-40°C \le T_A \le +85°C$
Supply Voltage (V_{CC})	4.5 V_{DC} to 6.3 V_{DC}

Electrical Characteristics

The following specifications apply for $V_{CC} = +5\ V_{DC}$, $V_{REF} = +2.5\ V_{DC}$ and $f_{CLK} = 4$ MHz, $R_{Source} = 50\Omega$ unless otherwise specified. **Boldface limits apply for $T_A = T_J = T_{MIN}$ to T_{MAX};** all other limits $T_A = T_J = 25°C$.

Symbol	Parameter	Conditions	ADC08231, ADC08234 and ADC08238 with BIN, CIN, BIWM, CIWM, or CIMF Suffixes		Units (Limits)
			Typical (Note 8)	Limits (Note 9)	
CONVERTER AND MULTIPLEXER CHARACTERISTICS					
	Linearity Error	$V_{REF} = +2.5\ V_{DC}$			
	BIN, BIWM			**±½**	LSB (max)
	CIN, CIMF, CIWM			**±1**	LSB (max)
	Gain Error	$V_{REF} = +2.5\ V_{DC}$			
	BIN, BIWM			**±1**	LSB (max)
	CIN, CIMF, CIWM			**±1**	LSB (max)
	Zero Error	$V_{REF} = +2.5\ V_{DC}$			
	BIN, BIWM			**±1**	LSB (max)
	CIN, CIMF, CIWM			**±1**	LSB (max)
	Total Unadjusted Error	$V_{REF} = +5\ V_{DC}$			
	BIN, BIWM	(Note 10)		**±1**	LSB (max)
	CIN, CIMF, CIWM			**±1**	LSB (max)
	Differential Linearity	$V_{REF} = +2.5\ V_{DC}$		**8**	Bits (min)
R_{REF}	Reference Input Resistance	(Note 11)	3.5		kΩ
				1.3	kΩ (min)
				6.0	kΩ (max)
V_{IN}	Analog Input Voltage	(Note 12)		**(V_{CC} + 0.05)**	V (max)
				(GND − 0.05)	V (min)

Electrical Characteristics (Continued)

The following specifications apply for $V_{CC} = +5\ V_{DC}$, $V_{REF} = +2.5\ V_{DC}$ and $f_{CLK} = 4$ MHz, $R_{source} = 50\Omega$ unless otherwise specified. **Boldface limits apply for $T_A = T_J = T_{MIN}$ to T_{MAX};** all other limits $T_A = T_J = 25°C$.

Symbol	Parameter	Conditions	ADC08231, ADC08234 and ADC08238 with BIN, CIN, BIWM, CIWM, or CIMF Suffixes		Units (Limits)
			Typical (Note 8)	Limits (Note 9)	
CONVERTER AND MULTIPLEXER CHARACTERISTICS (Continued)					
	DC Common-Mode Error	$V_{REF} = +2.5\ V_{DC}$		±½	LSB (max)
	Power Supply Sensitivity	$V_{CC} = +5V \pm 5\%$, $V_{REF} = +2.5\ V_{DC}$		±¼	LSB (max)
	On Channel Leakage Current (Note 13)	On Channel = 5V, Off Channel = 0V		0.2 **1**	μA (max)
		On Channel = 0V, Off Channel = 5V		−0.2 **−1**	μA (max)
	Off Channel Leakage Current (Note 13)	On Channel = 5V, Off Channel = 0V		−0.2 **−1**	μA (max)
		On Channel = 0V, Off Channel = 5V		0.2 **1**	μA (max)
DYNAMIC CHARACTERISTICS (see Typical Converter Performance Characteristics)					
$\frac{S}{N+D}$	Signal-to-(Noise + Distortion) Ratio	$V_{REF} = +5V$, Sample Rate = 286 kHz, $V_{IN} = +5\ V_{p-p}$			
		$f_{IN} = 10$ kHz	48.35		dB
		$f_{IN} = 50$ kHz	48.00		dB
		$f_{IN} = 100$ kHz	47.40		dB
DIGITAL AND DC CHARACTERISTICS					
$V_{IN(1)}$	Logical "1" Input Voltage	$V_{CC} = 5.25V$		**2.0**	V (min)
$V_{IN(0)}$	Logical "0" Input Voltage	$V_{CC} = 4.75V$		**0.8**	V (max)
$I_{IN(1)}$	Logical "1" Input Current	$V_{IN} = 5.0V$		**1**	μA (max)
$I_{IN(0)}$	Logical "0" Input Current	$V_{IN} = 0V$		**−1**	μA (max)
$V_{OUT(1)}$	Logical "1" Output Voltage	$V_{CC} = 4.75V$: $I_{OUT} = -360\ \mu A$ $I_{OUT} = -10\ \mu A$		 **2.4** **4.5**	 V (min) V (min)
$V_{OUT(0)}$	Logical "0" Output Voltage	$V_{CC} = 4.75V$ $I_{OUT} = 1.6$ mA		**0.4**	V (max)
I_{OUT}	TRI-STATE® Output Current	$V_{OUT} = 0V$ $V_{OUT} = 5V$		**−3.0** **3.0**	μA (max) μA (max)
I_{SOURCE}	Output Source Current	$V_{OUT} = 0V$		**−6.5**	mA (min)
I_{SINK}	Output Sink Current	$V_{OUT} = V_{CC}$		**8.0**	mA (min)
I_{CC}	Supply Current ADC08234, ADC08238 ADC08231 (Note 16)	$\overline{CS}$ = HIGH		 **3.0** **6.0**	 mA (max) mA (max)

Electrical Characteristics (Continued)

The following specifications apply for $V_{CC} = +5\ V_{DC}$ and $f_{CLK} = 4$ MHz unless otherwise specified. **Boldface limits apply for $T_A = T_J = T_{MIN}$ to T_{MAX};** all other limits $T_A = T_J = 25°C$.

Symbol	Parameter	Conditions	ADC08231, ADC08234 and ADC08238 with BIN, CIN, BIWM, CIWM, or CIMF Suffixes		Units (Limits)
			Typical (Note 8)	Limits (Note 9)	
REFERENCE CHARACTERISTICS					
$V_{REF}OUT$	Output Voltage	BIN, BIJ, BIWM	**2.5 ±2%**	2.5 ±1.5%	V
		CIN, CIJ, CIWM, CMJ	**2.5 ±3.5%**	2.5 ±3.0%	
$\Delta V_{REF}/\Delta T$	Temperature Coefficient		40		ppm/°C
$\Delta V_{REF}/\Delta I_L$	Load Regulation (Note 17)	Sourcing ($0 \le I_L \le +4$ mA) ADC08234, ADC08238	0.003	**0.1**	%/mA (max)
		Sourcing ($0 \le I_L \le +2$ mA) ADC08231	0.003	**0.1**	
		Sinking ($-1 \le I_L \le 0$ mA) ADC08234, ADC08238	0.2	**0.5**	
		Sinking ($-1 \le I_L \le 0$ mA) ADC08231	0.2	**0.5**	
	Line Regulation	$4.75V \le V_{CC} \le 5.25V$	0.5	**6**	mV (max)
I_{SC}	Short Circuit Current	$V_{REF} = 0V$ ADC08234, ADC08238	8	**25**	mA (max)
		$V_{REF} = 0V$ ADC08231	8	**25**	
T_{SU}	Start-Up Time	V_{CC}: 0V $\rightarrow$ 5V $C_L = 100\ \mu F$	20		ms
$\Delta V_{REF}/\Delta t$	Long Term Stability		200		ppm/1 kHr

Electrical Characteristics (Continued)

The following specifications apply for $V_{CC} = +5\ V_{DC}$, $V_{REF} = +2.5\ V_{DC}$ and $t_r = t_f = 20$ ns unless otherwise specified. **Boldface limits apply for $T_A = T_J = T_{MIN}$ to T_{MAX};** all other limits $T_A = T_J = 25°C$.

Symbol	Parameter	Conditions	Typical (Note 8)	Limits (Note 9)	Units (Limits)
f_{CLK}	Clock Frequency		10	**4**	kHz (min) MHz (max)
	Clock Duty Cycle (Note 14)			**40** **60**	% (min) % (max)
T_C	Conversion Time (Not Including MUX Addressing Time)	$f_{CLK} = 4$ MHz		**8** **2**	$1/f_{CLK}$ (max) μs (max)
t_{CA}	Acquisition Time			**1½**	$1/f_{CLK}$(max)
t_{SELECT}	CLK High while $\overline{CS}$ is High		50		ns
t_{SET-UP}	$\overline{CS}$ Falling Edge or Data Input Valid to CLK Rising Edge			**25**	ns (min)
t_{HOLD}	Data Input Valid after CLK Rising Edge			**20**	ns (min)
t_{pd1}, t_{pd0}	CLK Falling Edge to Output Data Valid (Note 15)	$C_L = 100$ pF: Data MSB First Data LSB First		 **250** **200**	 ns (max) ns (max)
t_{1H}, t_{0H}	TRI-STATE Delay from Rising Edge of $\overline{CS}$ to Data Output and SARS Hi-Z	$C_L = 10$ pF, $R_L = 10$ kΩ (see TRI-STATE Test Circuits)	50		ns
		$C_L = 100$ pF, $R_L = 2$ kΩ		**180**	ns (max)
C_{IN}	Capacitance of Logic Inputs		5		pF
C_{OUT}	Capacitance of Logic Outputs		5		pF

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur.

Note 2: Operating Ratings indicate conditions for which the device is functional. These ratings do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

Note 3: All voltages are measured with respect to AGND = DGND = 0 V_{DC}, unless otherwise specified.

Note 4: When the input voltage (V_{IN}) at any pin exceeds the power supplies ($V_{IN} <$ (AGND or DGND) or $V_{IN} > AV_{CC}$,) the current at that pin should be limited to 5 mA. The 20 mA maximum package input current rating limits the number of pins that can safely exceed the power supplies with an input current of 5 mA to four pins.

Note 5: The maximum power dissipation must be derated at elevated temperatures and is dictated by $T_{J_{MAX}}$, θ_{JA} and the ambient temperature, T_A. The maximum allowable power dissipation at any temperature is $P_D = (T_{J_{MAX}} - T_A)/\theta_{JA}$ or the number given in the Absolute Maximum Ratings, whichever is lower. For devices with suffixes BIN, CIN, BIJ, CIJ, BIWM, and CIWM $T_{J_{MAX}} = 125°C$. For devices with suffix CMJ, $T_{J_{MAX}} = 150°C$. The typical thermal resistances (θ_{JA}) of these parts when board mounted follow: ADC08231 with BIN and CIN suffixes 120°C/W, ADC08234 with BIN and CIN suffixes 95°C/W, ADC08234 with CIMF suffix 167°C/W, ADC08238 with BIN and CIN suffixes 80°C/W. ADC08231 with BIWM and CIWM suffixes 140°C/W, ADC08234 with BIWM and CIWM suffixes 140°C/W, ADC08238 with BIWM and CIWM suffixes 91°C/W,

Note 6: Human body model, 100 pF capacitor discharged through a 1.5 kΩ resistor.

Note 7: See AN450 ''Surface Mounting Methods and Their Effect on Product Reliability'' or *Linear Data Book* section ''Surface Mount'' for other methods of soldering surface mount devices.

Note 8: Typicals are at $T_J = 25°C$ and represent the most likely parametric norm.

Note 9: Guaranteed to National's AOQL (Average Outgoing Quality Level).

Note 10: Total unadjusted error includes zero, full-scale, linearity, and multiplexer error. Total unadjusted error with $V_{REF} = +5V$ only applies to the ADC08234 and ADC08238. See Note 16.

Note 11: Cannot be tested for the ADC08231.

Note 12: For $V_{IN(-)} \geq V_{IN(+)}$ the digital code will be 0000 0000. Two on-chip diodes are tied to each analog input (see Block Diagram) which will forward-conduct for analog input voltages one diode drop below ground or one diode drop greater than V_{CC} supply. During testing at low V_{CC} levels (e.g., 4.5V), high level analog inputs (e.g., 5V) can cause an input diode to conduct, especially at elevated temperatures. This will cause errors for analog inputs near full-scale. The specification allows 50 mV forward bias of either diode; this means that as long as the analog V_{IN} does not exceed the supply voltage by more than 50 mV, the output code will be correct. Exceeding this range on an unselected channel will corrupt the reading of a selected channel. Achievement of an absolute 0 V_{DC} to 5 V_{DC} input voltage range will therefore require a minimum supply voltage of 4.950 V_{DC} over temperature variations, initial tolerance and loading.

Note 13: Channel leakage current is measured after a single-ended channel is selected and the clock is turned off. For off channel leakage current the following two cases are considered: one, with the selected channel tied high (5 V_{DC}) and the remaining off channels tied low (0 V_{DC}), total current flow through the off channels is measured; two, with the selected channel tied low and the off channels tied high, total current flow through the off channels is again measured. The two cases considered for determining on channel leakage current are the same except total current flow through the selected channel is measured.

Note 14: A 40% to 60% duty cycle range insures proper operation at all clock frequencies. In the case that an available clock has a duty cycle outside of these limits the minimum time the clock is high or low must be at least 120 ns. The maximum time the clock can be high or low is 100 μs.

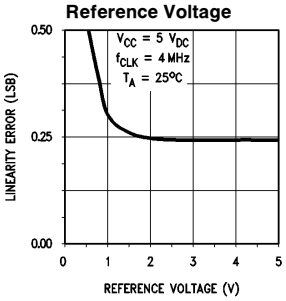
Note 15: Since data, MSB first, is the output of the comparator used in the successive approximation loop, an additional delay is built in (see Block Diagram) to allow for comparator response time.

Note 16: For the ADC08231 V_{REF}IN is internally tied to the on chip 2.5V band-gap reference output; therefore, the supply current is larger because it includes the reference current (700 μA typical, 2 mA maximum).

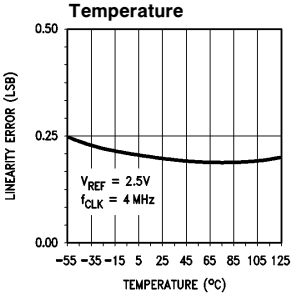
Note 17: Load regulation test conditions and specifications for the ADC08231 differ from those of the ADC08234 and ADC08238 because the ADC08231 has the on-board reference as a permanent load.

Typical Performance Characteristics

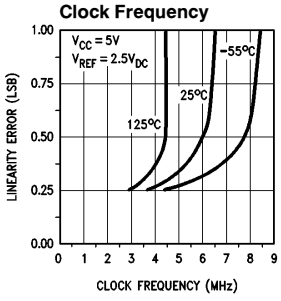
Linearity Error vs Reference Voltage



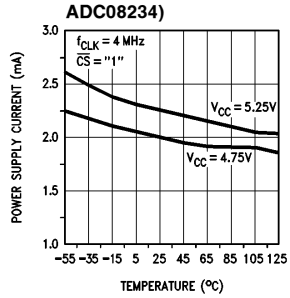
Linearity Error vs Temperature



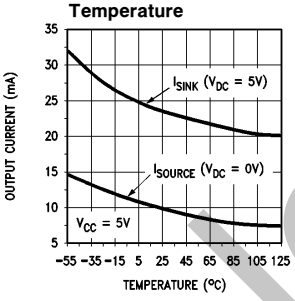
Linearity Error vs Clock Frequency



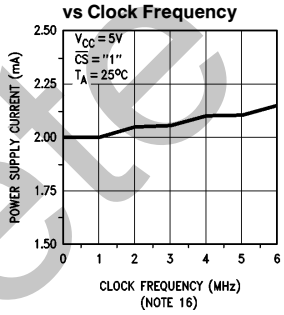
Power Supply Current vs Temperature (ADC08238, ADC08234)



Output Current vs Temperature



Power Supply Current vs Clock Frequency



Note: For ADC08231 add I_{REF} (Note 16)

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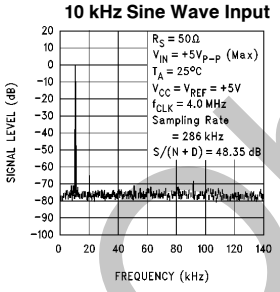
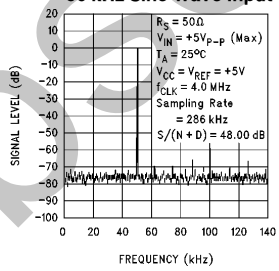
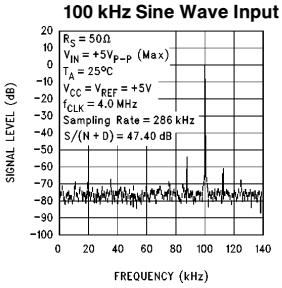
Spectral Response with 10 kHz Sine Wave Input



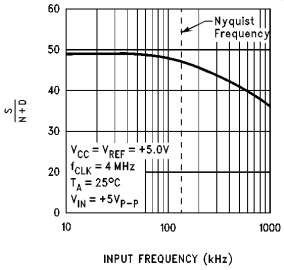
Spectral Response with 50 kHz Sine Wave Input



Spectral Response with 100 kHz Sine Wave Input



Signal-to-Noise + Distortion Ratio vs Input Frequency



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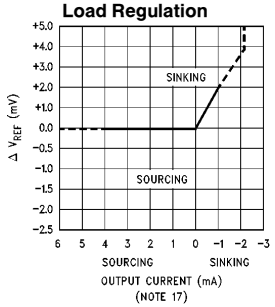
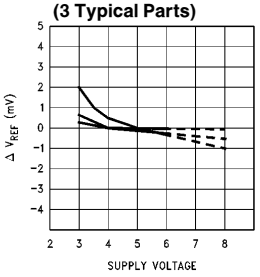
Typical Reference Performance Characteristics

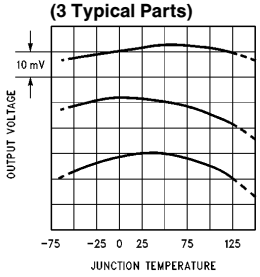
Load Regulation



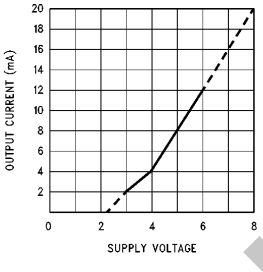
Line Regulation (3 Typical Parts)



Output Drift vs Temperature (3 Typical Parts)

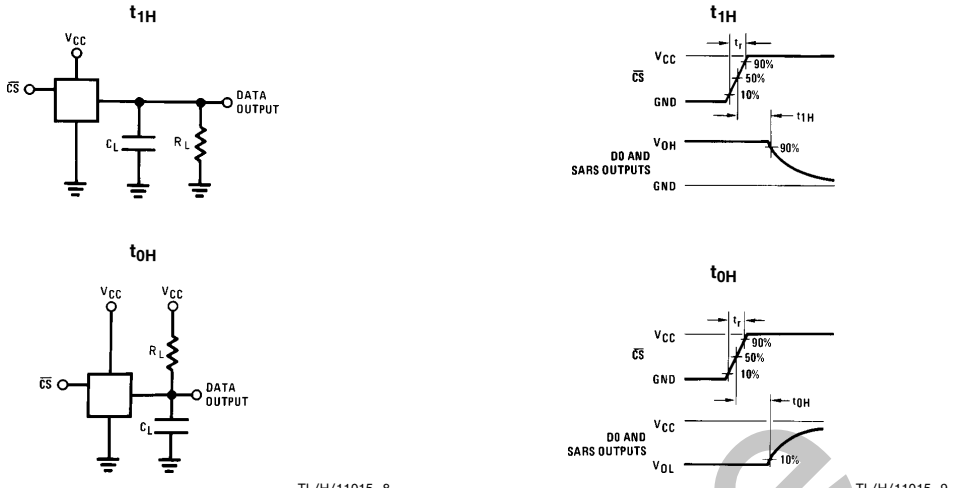


Available Output Current vs Supply Voltage



TL/H/11015–7

TRI-STATE Test Circuits and Waveforms

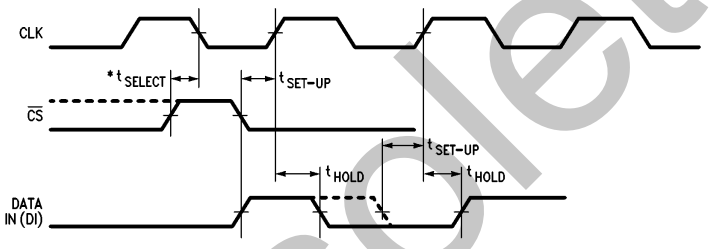


TL/H/11015–8

TL/H/11015–9

Timing Diagrams

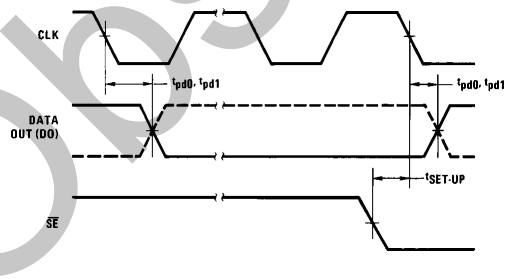
Data Input Timing



TL/H/11015–10

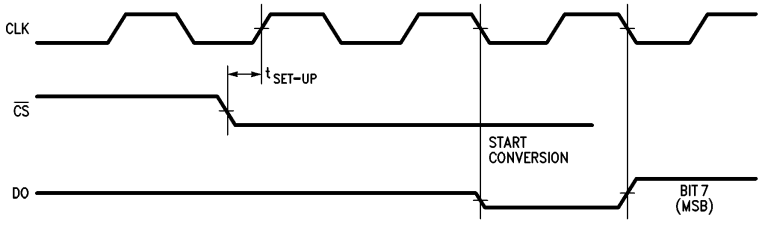
*To reset these devices, CLK and $\overline{CS}$ must be simultaneously high for a period of t_{SELECT} or greater.

Data Output Timing



TL/H/11015–11

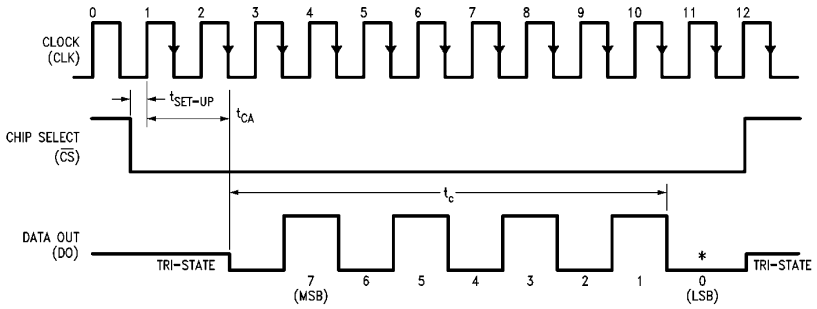
ADC08231 Start Conversion Timing



TL/H/11015–12

Timing Diagrams (Continued)

ADC08231 Timing



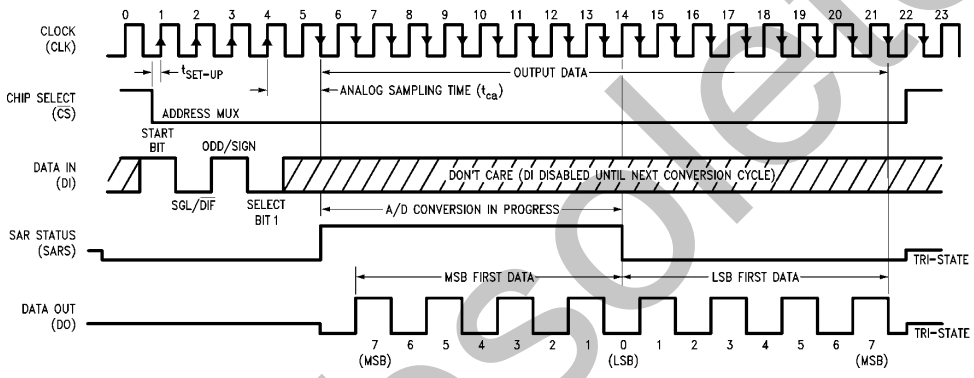
TL/H/11015–13

*LSB first output not available on ADC08231.

LSB information is maintained for remainder of clock periods until $\overline{CS}$ goes high.

To reset the ADC08231, CLK and $\overline{CS}$ must be simultaneously high for a period of t_{SELECT} or greater. The ADC08231 also has one extra clock period for sampling the analog signal (t_{ca}). Otherwise it is compatible with the ADC0831.

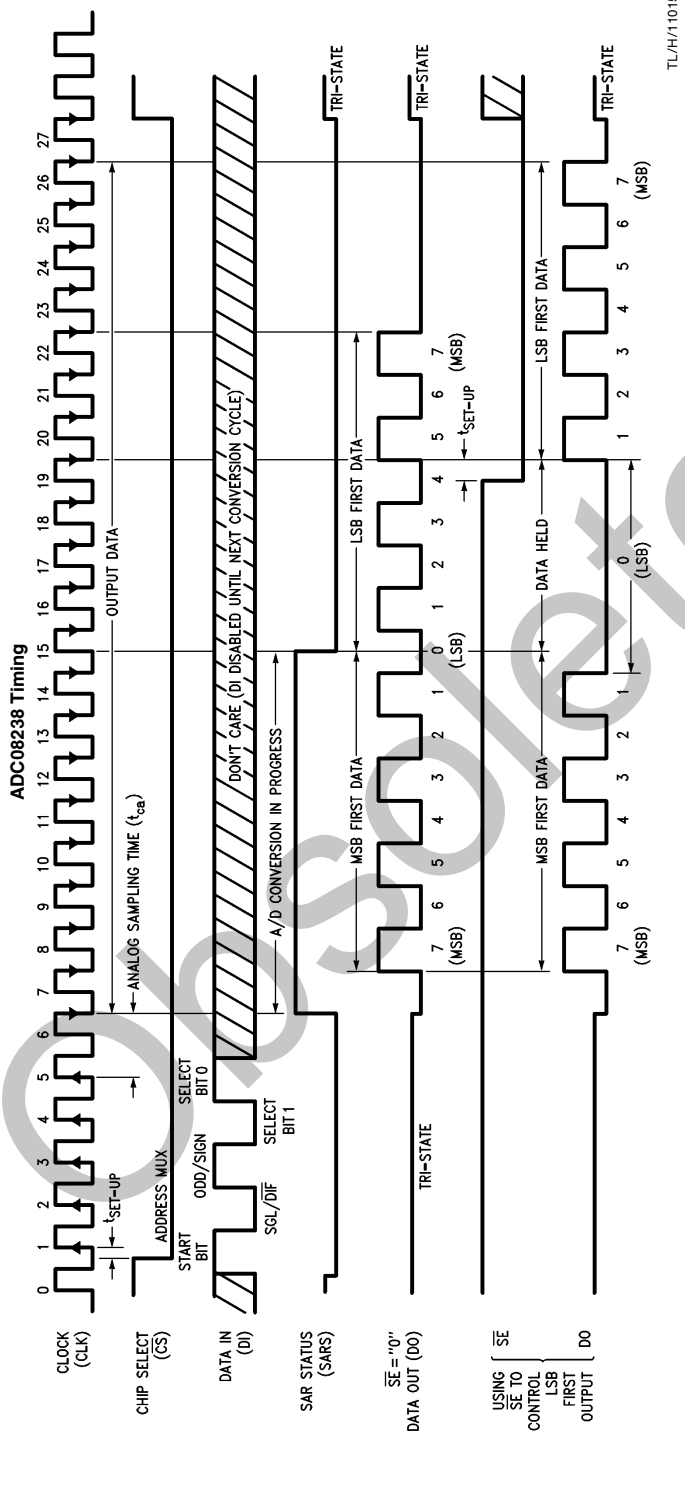
ADC08234 Timing



TL/H/11015–14

To reset the ADC08234, CLK and $\overline{CS}$ must be simultaneously high for a period of t_{SELECT} or greater. The ADC08234 also has one extra clock period for sampling the analog signal (t_{ca}). Otherwise it is compatible with the ADC0834.

Timing Diagrams (Continued)

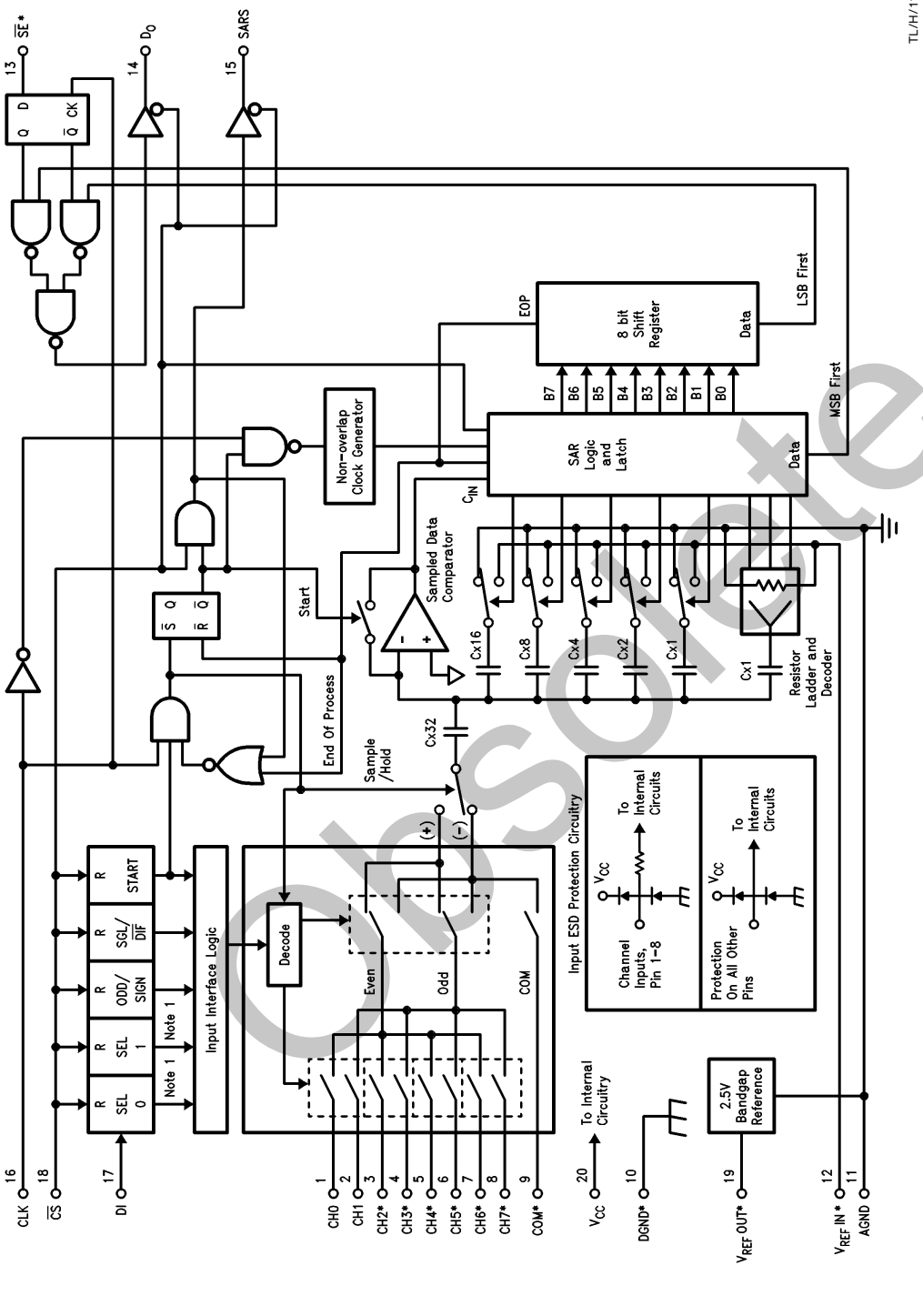


TL/H/11015–15

*Make sure clock edge #19 clocks in the LSB before $\overline{SE}$ is taken low

To reset the ADC08238, CLK and $\overline{CS}$ must be simultaneously high for a period of t_{SELECT} or greater. The ADC08238 also has one extra clock period for sampling the analog signal (t_{ca}). Otherwise it is compatible with the ADC0838.

ADC08238 Functional Block Diagram



TL/H/11015–16

*Some of these functions/pins are not available with other options.

Note 1: For the ADC08234, the "SEL 1" Flip-Flop is bypassed. For the ADC08231, V_{REFOUT} and V_{REFIN} are internally tied together.

Functional Description

1.0 MULTIPLEXER ADDRESSING

The design of these converters utilizes a comparator structure with built-in sample-and-hold which provides for a differential analog input to be converted by a successive-approximation routine.

The actual voltage converted is always the difference between an assigned "+" input terminal and a "−" input terminal. The polarity of each input terminal of the pair indicates which line the converter expects to be the most positive. If the assigned "+" input voltage is less than the "−" input voltage the converter responds with an all zeros output code.

A unique input multiplexing scheme has been utilized to provide multiple analog channels with software-configurable single-ended, differential, or pseudo-differential (which will convert the difference between the voltage at any analog input and a common terminal) operation. The analog signal conditioning required in transducer-based data acquisition systems is significantly simplified with this type of input flexibility. One converter package can now handle ground referenced inputs and true differential inputs as well as signals with some arbitrary reference voltage.

A particular input configuration is assigned during the MUX addressing sequence, prior to the start of a conversion. The MUX address selects which of the analog inputs are to be enabled and whether this input is single-ended or differential. Differential inputs are restricted to adjacent channel pairs. For example, channel 0 and channel 1 may be selected as a differential pair but channel 0 or 1 cannot act differentially with any other channel. In addition to selecting differential mode the polarity may also be selected. Channel 0 may be selected as the positive input and channel 1 as the negative input or vice versa. This programmability is best illustrated by the MUX addressing codes shown in the following tables for the various product options.

The MUX address is shifted into the converter via the DI line. Because the ADC08231 contains only one differential input channel with a fixed polarity assignment, it does not require addressing.

The common input line (COM) on the ADC08238 can be used as a pseudo-differential input. In this mode the voltage on this pin is treated as the "−" input for any of the other input channels. This voltage does not have to be analog ground; it can be any reference potential which is common to all of the inputs. This feature is most useful in single-supply applications where the analog circuitry may be biased up to a potential other than ground and the output signals are all referred to this potential.

TABLE I. Multiplexer/Package Options

Part Number	Number of Analog Channels		Number of Package Pins
	Single-Ended	Differential	
ADC08231	1	1	8
ADC08234	4	2	14
ADC08238	8	4	20

TABLE II. MUX Addressing: ADC08238

Single-Ended MUX Mode

MUX Address					Analog Single-Ended Channel #								
START	SGL/$\overline{\text{DIF}}$	ODD/ SIGN	SELECT		0	1	2	3	4	5	6	7	COM
			1	0									
1	1	0	0	0	+								−
1	1	0	0	1			+						−
1	1	0	1	0					+				−
1	1	0	1	1							+		−
1	1	1	0	0		+							−
1	1	1	0	1				+					−
1	1	1	1	0						+			−
1	1	1	1	1								+	−

Functional Description (Continued)

TABLE II. MUX Addressing: ADC08238 (Continued)

Differential MUX Mode

MUX Address					Analog Differential Channel-Pair #							
START	SGL/$\overline{\text{DIF}}$	ODD/ SIGN	SELECT		0		1		2		3	
			1	0	0	1	2	3	4	5	6	7
1	0	0	0	0	+	−						
1	0	0	0	1			+	−				
1	0	0	1	0					+	−		
1	0	0	1	1							+	−
1	0	1	0	0	−	+						
1	0	1	0	1			−	+				
1	0	1	1	0					−	+		
1	0	1	1	1							−	+

TABLE III. MUX Addressing: ADC08234

Single-Ended MUX Mode

MUX Address				Channel #			
START	SGL/$\overline{\text{DIF}}$	ODD/ SIGN	SELECT	0	1	2	3
			1				
1	1	0	0	+			
1	1	0	1			+	
1	1	1	0		+		
1	1	1	1				+

COM is internally tied to AGND

Differential MUX Mode

MUX Address				Channel #			
START	SGL/$\overline{\text{DIF}}$	ODD/ SIGN	SELECT	0	1	2	3
			1				
1	0	0	0	+	−		
1	0	0	1			+	−
1	0	1	0	−	+		
1	0	1	1			−	+

Functional Description (Continued)

Since the input configuration is under software control, it can be modified as required before each conversion. A channel can be treated as a single-ended, ground referenced input for one conversion; then it can be reconfigured as part of a differential channel for another conversion. *Figure 1* illustrates the input flexibility which can be achieved.

The analog input voltages for each channel can range from 50mV below ground to 50mV above V_{CC} (typically 5V) without degrading conversion accuracy.

2.0 THE DIGITAL INTERFACE

A most important characteristic of these converters is their serial data link with the controlling processor. Using a serial communication format offers two very significant system improvements; it allows many functions to be included in a small package and it can eliminate the transmission of low level analog signals by locating the converter right at the analog sensor; transmitting highly noise immune digital data back to the host processor.

To understand the operation of these converters it is best to refer to the Timing Diagrams and Functional Block Diagram and to follow a complete conversion sequence. For clarity a separate timing diagram is shown for each device.

1. A conversion is initiated by pulling the $\overline{CS}$ (chip select) line low. This line must be held low for the entire conversion. The converter is now waiting for a start bit and its MUX assignment word.
2. On each rising edge of the clock the status of the data in (DI) line is clocked into the MUX address shift register. The start bit is the first logic ''1'' that appears on this line (all leading zeros are ignored). Following the start bit the converter expects the next 2 to 4 bits to be the MUX assignment word.

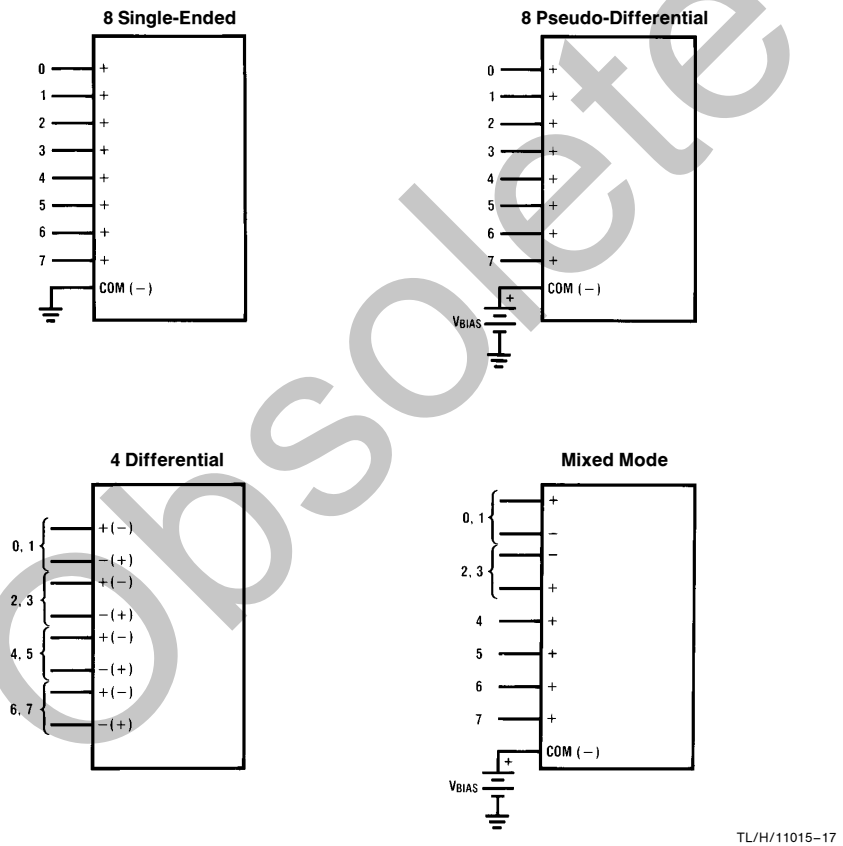


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FIGURE 1. Analog Input Multiplexer Options for the ADC08238

Functional Description (Continued)

3. When the start bit has been shifted into the start location of the MUX register, the input channel has been assigned and a conversion is about to begin. An interval of 1½ clock periods is automatically inserted to allow for sampling the analog input. The SARS line goes high at the end of this time to signal that a conversion is now in progress and the DI line is disabled (it no longer accepts data).
4. The data out (DO) line now comes out of TRI-STATE and provides a leading zero.
5. During the conversion the output of the SAR comparator indicates whether the analog input is greater than (high) or less than (low) a series of successive voltages generated internally from a ratioed capacitor array (first 5 bits) and a resistor ladder (last 3 bits). After each comparison the comparator's output is shipped to the DO line on the falling edge of CLK. This data is the result of the conversion being shifted out (with the MSB first) and can be read by the processor immediately.
6. After 8 clock periods the conversion is completed. The SARS line returns low to indicate this ½ clock cycle later.
7. The stored data in the successive approximation register is loaded into an internal shift register. If the programmer prefers, the data can be provided in an LSB first format [this makes use of the shift enable ($\overline{SE}$) control line]. On the ADC08238 the $\overline{SE}$ line is brought out and if held high the value of the LSB remains valid on the DO line. When $\overline{SE}$ is forced low the data is clocked out LSB first. On devices which do not include the $\overline{SE}$ control line, the data, LSB first, is automatically shifted out the DO line after the MSB first data stream. The DO line then goes low and stays low until $\overline{CS}$ is returned high. The ADC08231 is an exception in that its data is only output in MSB first format.
8. All internal registers are cleared when the $\overline{CS}$ line is high and the t_{SELECT} requirement is met. See Data Input Timing under Timing Diagrams. If another conversion is desired $\overline{CS}$ must make a high to low transition followed by address information.

   The DI and DO lines can be tied together and controlled through a bidirectional processor I/O bit with one wire. This is possible because the DI input is only "looked-at" during the MUX addressing interval while the DO line is still in a high impedance state.

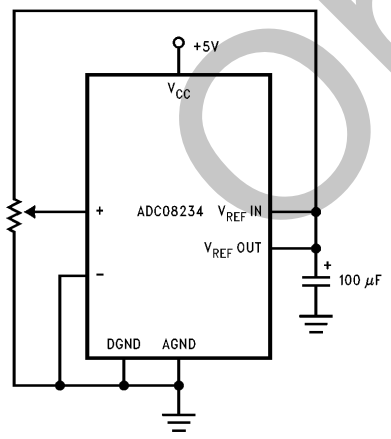
3.0 REFERENCE CONSIDERATIONS

The V_{REF}IN pin on these converters is the top of a resistor divider string and capacitor array used for the successive approximation conversion. The voltage applied to this reference input defines the voltage span of the analog input (the difference between $V_{IN(MAX)}$ and $V_{IN(MIN)}$ over which the 256 possible output codes apply). The reference source must be capable of driving the reference input resistance, which can be as low as 1.3 kΩ.

For absolute accuracy, where the analog input varies between specific voltage limits, the reference input must be biased with a stable voltage source. The ADC08234 and the ADC08238 provide the output of a 2.5V band-gap reference at V_{REF}OUT. This voltage does not vary appreciably with temperature, supply voltage, or load current (see Reference Characteristics in the Electrical Characteristics tables) and can be tied directly to V_{REF}IN for an analog input span of 0V to 2.5V. This output can also be used to bias external circuits and can therefore be used as the reference in ratiometric applications. Bypassing V_{REF}OUT with a 100 μF capacitor is recommended.

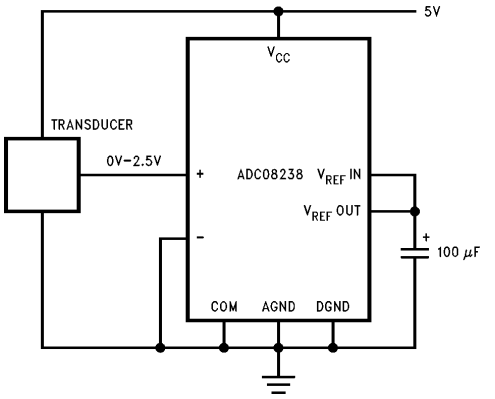
For the ADC08231, the output of the on-board reference is internally tied to the reference input. Consequently, the analog input span for this device is set at 0V to 2.5V. The pin V_{REF}C is provided for bypassing purposes and biasing external circuits as suggested above.

The maximum value of the reference is limited to the V_{CC} supply voltage. The minimum value, however, can be quite small (see Typical Performance Characteristics) to allow direct conversions of transducer outputs providing less than a 5V output span. Particular care must be taken with regard to noise pickup, circuit layout and system error voltage sources when operating with a reduced span due to the increased sensitivity of the converter (1 LSB equals V_{REF}/256).



TL/H/11015–18

a) Ratiometric



TL/H/11015–19

b) Absolute

FIGURE 2. Reference Examples

Functional Description (Continued)

4.0 THE ANALOG INPUTS

The most important feature of these converters is that they can be located right at the analog signal source and through just a few wires can communicate with a controlling processor with a highly noise immune serial bit stream. This in itself greatly minimizes circuitry to maintain analog signal accuracy which otherwise is most susceptible to noise pickup. However, a few words are in order with regard to the analog inputs should the input be noisy to begin with or possibly riding on a large common-mode voltage.

The differential input of these converters actually reduces the effects of common-mode input noise, a signal common to both selected "+" and "−" inputs for a conversion (60 Hz is most typical). The time interval between sampling the "+" input and then the "−" input is ½ of a clock period. The change in the common-mode voltage during this short time interval can cause conversion errors. For a sinusoidal common-mode signal this error is:

$$V_{error}(max) = V_{PEAK}(2\pi f_{CM})\left(\frac{0.5}{f_{CLK}}\right)$$

where f_{CM} is the frequency of the common-mode signal,

V_{PEAK} is its peak voltage value

and f_{CLK} is the A/D clock frequency.

For a 60Hz common-mode signal to generate a ¼ LSB error (≈5mV) with the converter running at 250kHz, its peak value would have to be 6.63V which would be larger than allowed as it exceeds the maximum analog input limits.

Source resistance limitation is important with regard to the DC leakage currents of the input multiplexer. While operating near or at maximum speed, bypass capacitors should not be used if the source resistance is greater than 1kΩ. The worst-case leakage current of ±1μA over temperature will create a 1mV input error with a 1kΩ source resistance. An op amp RC active low pass filter can provide both impedance buffering and noise filtering should a high impedance signal source be required.

5.0 OPTIONAL ADJUSTMENTS

5.1 Zero Error

The zero of the A/D does not require adjustment. If the minimum analog input voltage value, $V_{IN(MIN)}$, is not ground a zero offset can be done. The converter can be made to output 0000 0000 digital code for this minimum input voltage by biasing any V_{IN} (−) input at this $V_{IN(MIN)}$ value. This utilizes the differential mode operation of the A/D.

The zero error of the A/D converter relates to the location of the first riser of the transfer function and can be measured by grounding the V_{IN} (−) input and applying a small magnitude positive voltage to the V_{IN} (+) input. Zero error is the difference between the actual DC input voltage which is necessary to just cause an output digital code transition from 0000 0000 to 0000 0001 and the ideal ½ LSB value (½ LSB = 9.8mV for $V_{REF} = 5.000V_{DC}$).

5.2 Full Scale

A full-scale adjustment can be made by applying a differential input voltage which is 1½ LSB down from the desired analog full-scale voltage range and then adjusting the magnitude of the V_{REF}IN input for a digital output code which is just changing from 1111 1110 to 1111 1111 (See figure entitled "Span Adjust; $0V \leq V_{IN} \leq 3V$"). This is possible only with the ADC08234 and ADC08238. (The reference is internally connected to V_{REF}IN of the ADC08231).

5.3 Adjusting for an Arbitrary Analog Input Voltage Range

If the analog zero voltage of the A/D is shifted away from ground (for example, to accommodate an analog input signal which does not go to ground), this new zero reference should be properly adjusted first. A V_{IN} (+) voltage which equals this desired zero reference plus ½ LSB (where the LSB is calculated for the desired analog span, using 1 LSB = analog span/256) is applied to selected "+" input and the zero reference voltage at the corresponding "−" input should then be adjusted to just obtain the 00_{HEX} to 01_{HEX} code transition.

The full-scale adjustment should be made [with the proper V_{IN} (−) voltage applied] by forcing a voltage to the V_{IN} (+) input which is given by:

$$V_{IN}(+) \text{ fs adj} = V_{MAX} - 1.5\left[\frac{(V_{MAX} - V_{MIN})}{256}\right]$$

where:

V_{MAX} = the high end of the analog input range

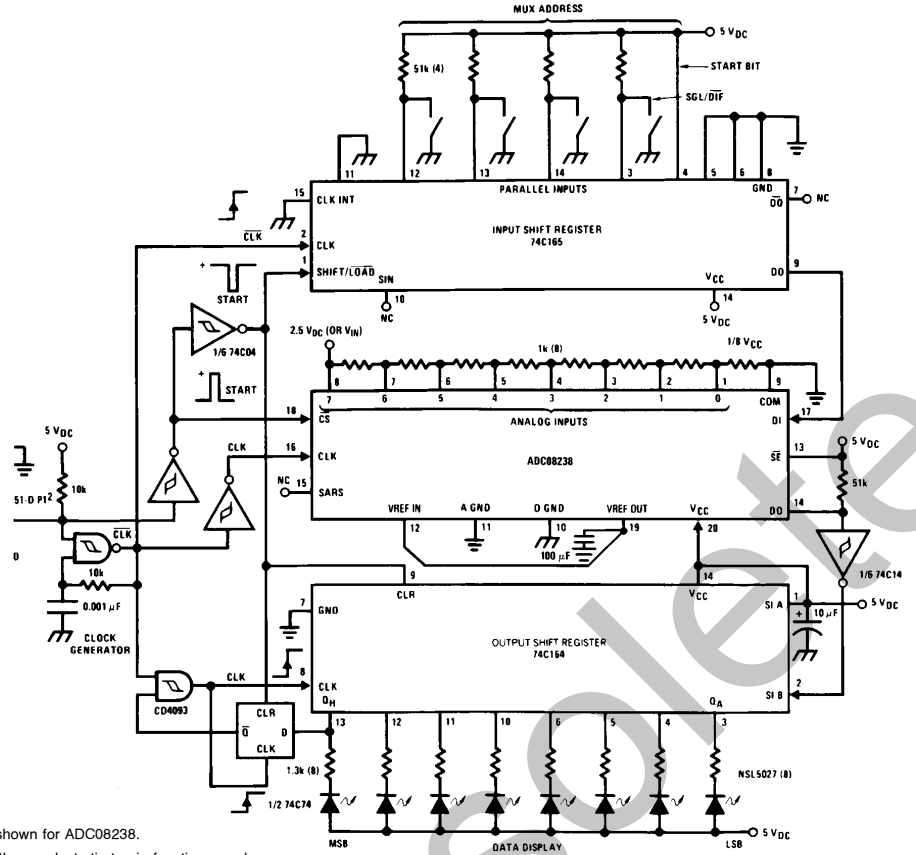
and

V_{MIN} = the low end (the offset zero) of the analog range. (Both are ground referenced.)

The V_{REF}IN (or V_{CC}) voltage is then adjusted to provide a code change from FE_{HEX} to FF_{HEX}. This completes the adjustment procedure.

Applications

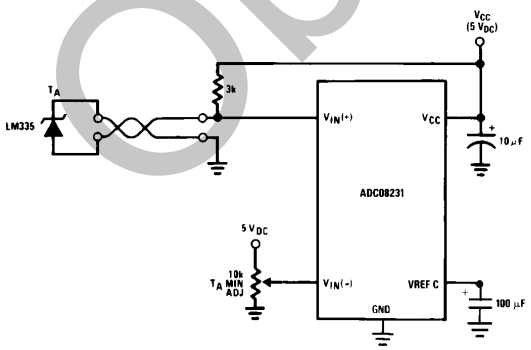
A "Stand-Alone" Hook-Up for ADC08238 Evaluation



*Pinouts shown for ADC08238.

For all other products tie to pin functions as shown.

Low-Cost Remote Temperature Sensor



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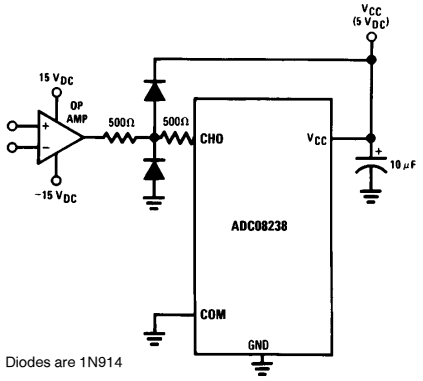
Applications (Continued)

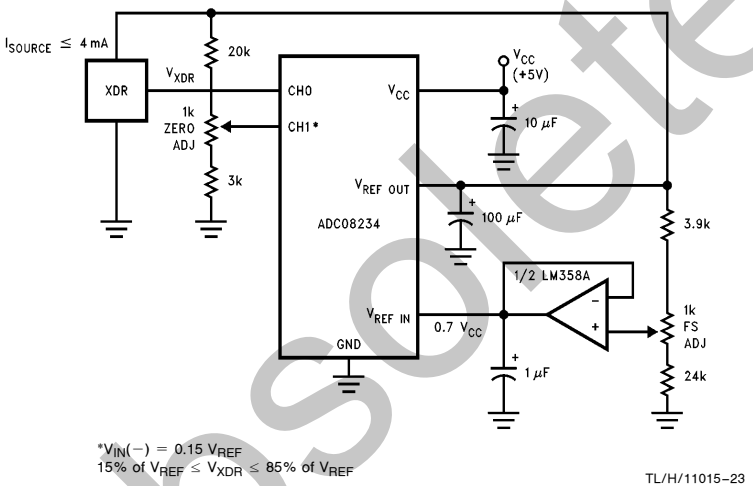
Protecting the Input



Diodes are 1N914

TL/H/11015–22

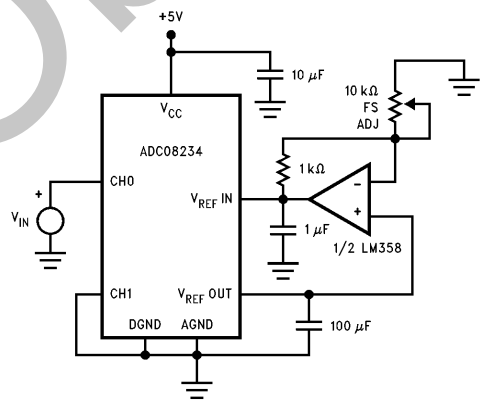
Operating with Ratiometric Transducers



*$V_{IN}(-) = 0.15\ V_{REF}$
15% of $V_{REF} \leq V_{XDR} \leq$ 85% of V_{REF}

TL/H/11015–23

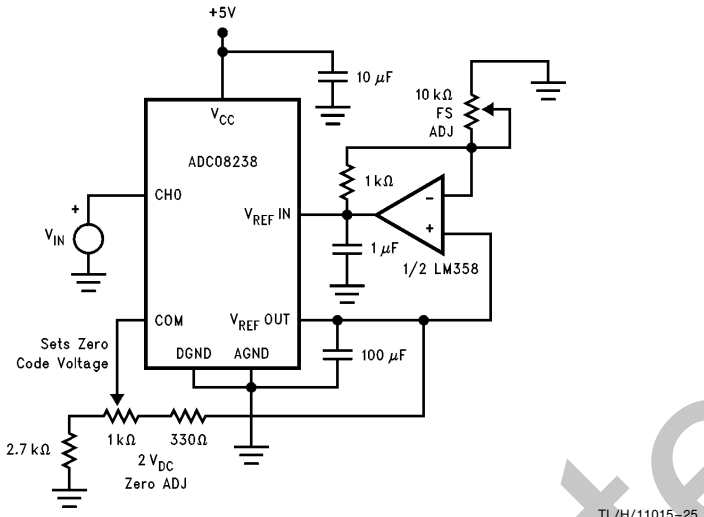
Span Adjust; 0V $\leq V_{IN} \leq$ 3V



TL/H/11015–24

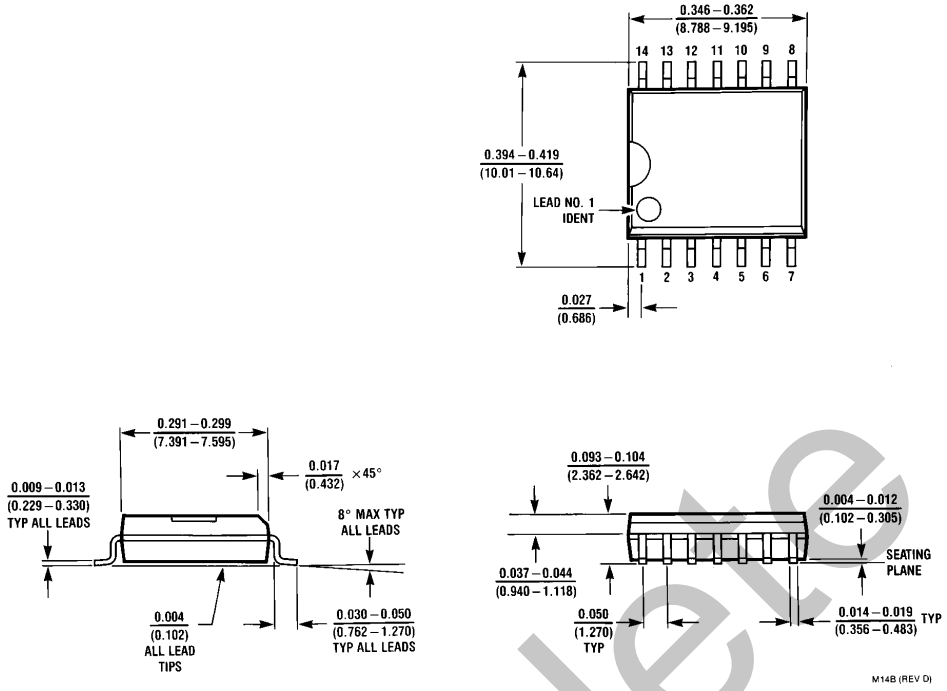
Applications (Continued)

Zero-Shift and Span Adjust: 2V ≤ V_{IN} ≤ 5V

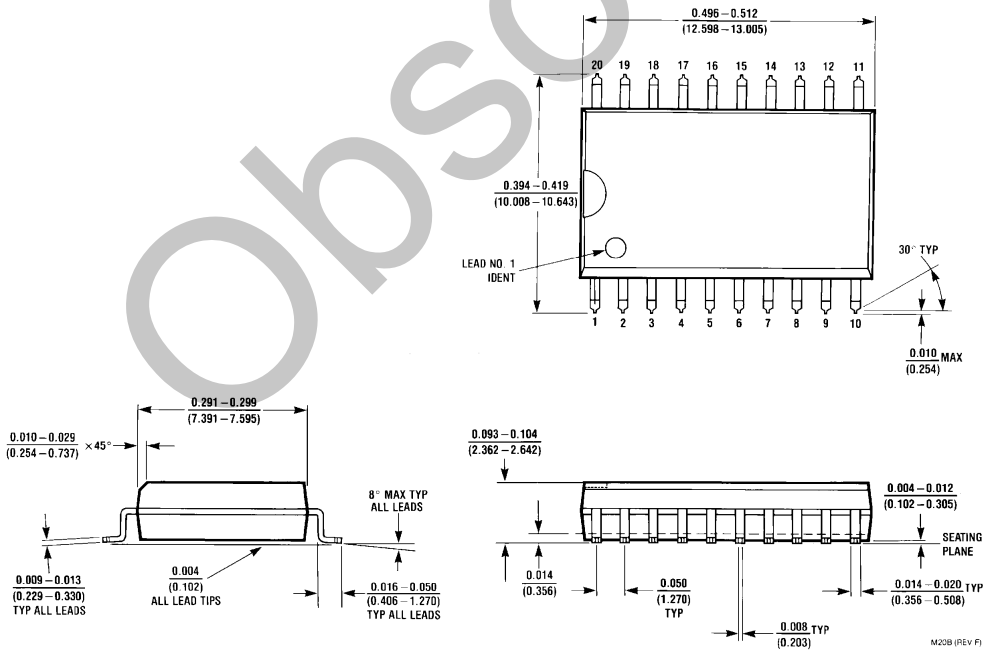


TL/H/11015–25

Physical Dimensions inches (millimeters)

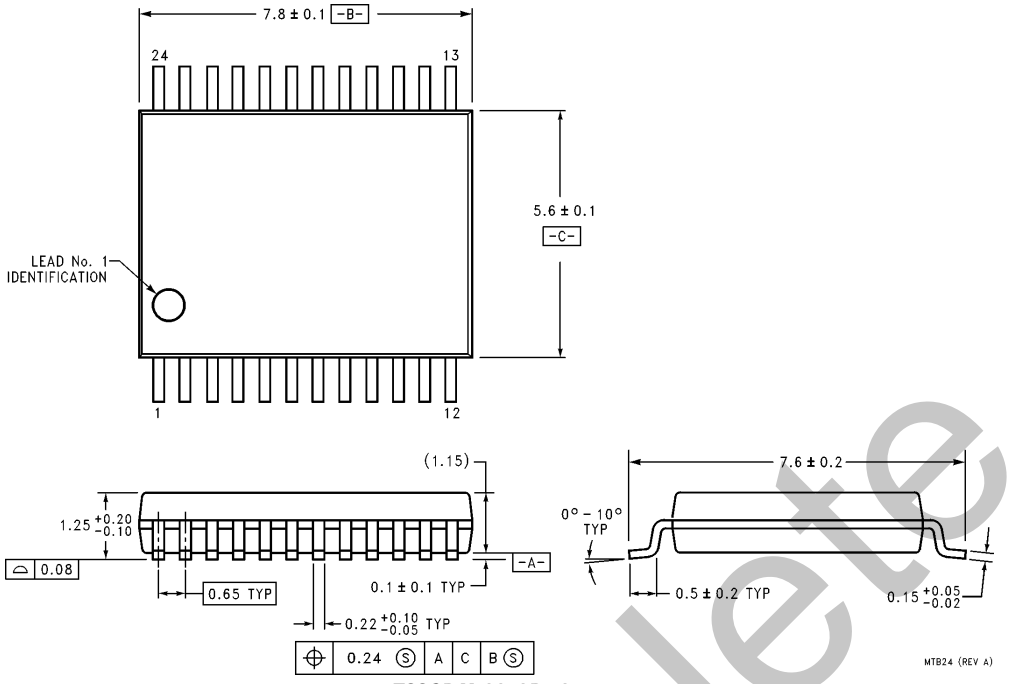


Order Number ADC08231BIWM, ADC08231CIWM,
ADC08234BIWM or ADC08234CIWM
NS Package Number M14B

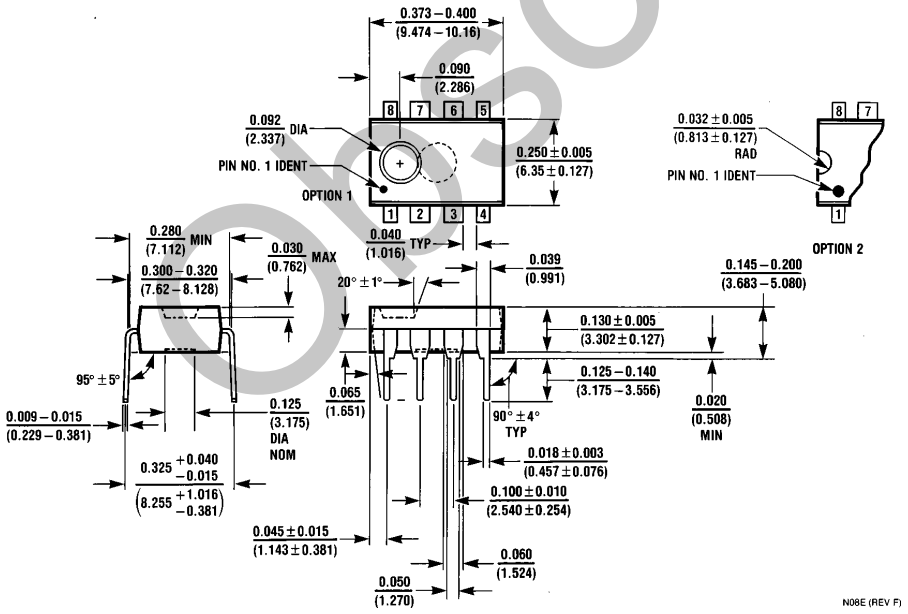


Order Number ADC08238BIWM or ADC08238CIWM
NS Package Number M20B

Physical Dimensions inches (millimeters) (Continued)

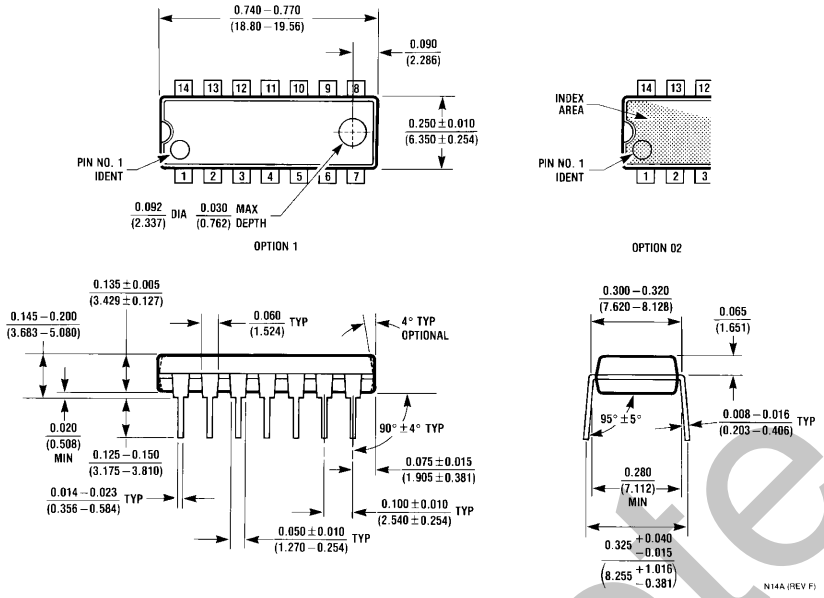


TSSOP Molded Package
Order Number ADC08234CIMF
NS Package Number MTB24



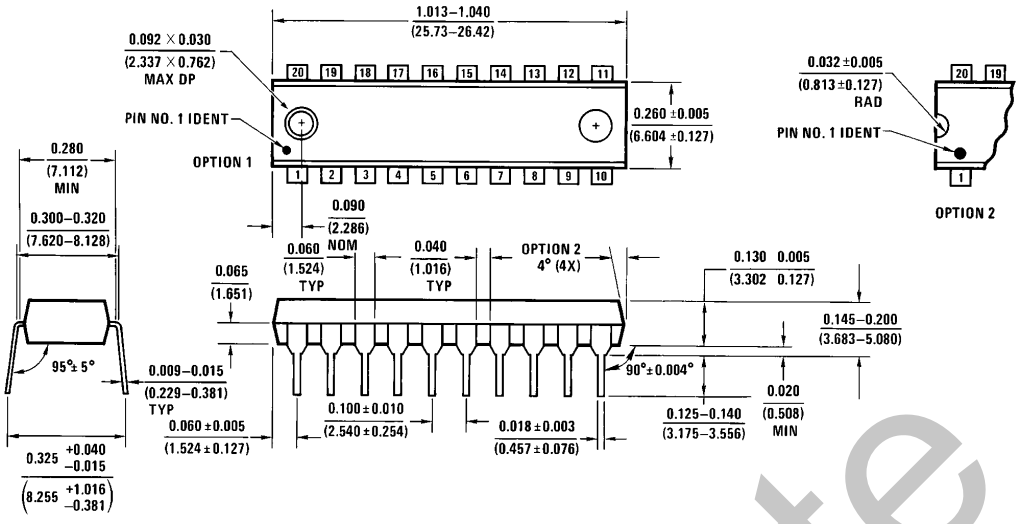
Order Number ADC08231BIN or ADC08231CIN
NS Package Number N08E

Physical Dimensions inches (millimeters) (Continued)



Molded Dual-In-Line Package (N)
Order Number ADC08234BIN or ADC08234CIN
NS Package Number N14A

Physical Dimensions inches (millimeters) (Continued)



Molded Dual-In-Line Package (N)
Order Number ADC08238CIN or ADC08238BIN
NS Package Number N20A

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